

DATA SHEET

Order code	Manufacturer code	Description	
47-0564	NTP30N06LG	NTP30N06LG MOSFET LOGIC N 60V 30A (RC)	

	Page 1 of 9
The enclosed information is believed to be correct, Information may change ±without noticeqdue to product improvement. Users should ensure that the product is suitable for their use. E. & O. E.	Revision A 20/02/2007

Sales: 01206 751166 Sales@rapidelec.co.uk Technical: 01206 835555 Tech@rapidelec.co.uk Fax: 01206 751188 www.rapidonline.com

Power MOSFET

30 Amps, 60 Volts, Logic Level, N-Channel TO-220 and D²PAK

Designed for low voltage, high speed switching applications in power supplies, converters and power motor controls and bridge circuits.

Features

• Pb-Free Packages are Available

Typical Applications

- Power Supplies
- Converters
- Power Motor Controls
- Bridge Circuits

MAXIMUM RATINGS (T_{.I} = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	60	Vdc
Drain-to-Gate Voltage ($R_{GS} = 10 \text{ M}\Omega$)	V_{DGR}	60	Vdc
Gate-to-Source Voltage - Continuous - Non-Repetitive (t _p ≤10 ms)	V _{GS} V _{GS}	±15 ±20	Vdc
$ \begin{array}{ll} \text{Drain Current} & -\text{ Continuous } @\text{ T}_A = 25^\circ\text{C} \\ -\text{ Continuous } @\text{ T}_A = 100^\circ\text{C} \\ -\text{ Single Pulse } (t_p \! \leq \! 10 \ \mu\text{s}) \end{array} $	I _D I _D I _{DM}	30 15 90	Adc Apk
Total Power Dissipation @ T _A = 25°C Derate above 25°C	P _D	88.2 0.59	W W/°C
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to +175	°C
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^{\circ}C$ ($V_{DD} = 50$ Vdc, $V_{GS} = 5.0$ Vdc, $L = 0.3$ mH $I_{L(pk)} = 26$ A, $V_{DS} = 60$ Vdc)	E _{AS}	101	mJ
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	1.7	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8 in from case for 10 seconds	TL	260	°C

Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

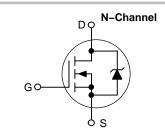


ON Semiconductor®

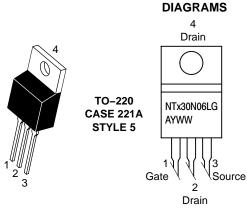
http://onsemi.com

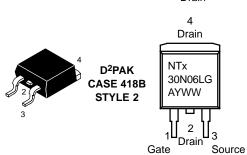
30 AMPERES, 60 VOLTS

 $R_{DS(on)} = 46 \text{ m}\Omega$



MARKING





NTx30N06L = Device Code x = P or B

A = Assembly Location

Y = Year
WW = Work Week
G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS				•	•	•
Drain-to-Source Breakdown Voltage (Note 1) (V _{GS} = 0 Vdc, I _D = 250 μAdc) Temperature Coefficient (Positive)			60 -	71.8 69	_ _	Vdc mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vdc})$ $(V_{DS} = 60 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T_{J} = 150^{\circ}\text{C})$			- -	- -	1.0 10	μAdc
Gate-Body Leakage Current (V _G	$_{\rm S}$ = ±15 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	_	-	±100	nAdc
ON CHARACTERISTICS (Note 1)						
Gate Threshold Voltage (Note 1) $(V_{DS} = V_{GS}, I_D = 250 \mu Adc)$ Threshold Temperature Coefficie	nt (Negative)	V _{GS(th)}	1.0	1.7 4.8	2.0	Vdc mV/°C
Static Drain-to-Source On-Resistance (Note 1) (V _{GS} = 5.0 Vdc, I _D = 15 Adc)			-	38	46	mΩ
Static Drain-to-Source On-Voltage (Note 1) ($V_{GS} = 5.0 \text{ Vdc}$, $I_D = 30 \text{ Adc}$) ($V_{GS} = 5.0 \text{ Vdc}$, $I_D = 15 \text{ Adc}$, $T_J = 150^{\circ}\text{C}$)				1.3 1.06	1.7	Vdc
Forward Transconductance (Note 1) (V _{DS} = 7.0 Vdc, I _D = 15 Adc)			_	21	_	mhos
DYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	_	810	1150	pF
Output Capacitance	$(V_{DS} = 25 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, f = 1.0 \text{ MHz})$	C _{oss}	_	260	370	
Transfer Capacitance	,	C_{rss}	_	80	115	
SWITCHING CHARACTERISTICS	(Note 2)					
Turn-On Delay Time		t _{d(on)}	_	10	20	ns
Rise Time	$(V_{DD} = 30 \text{ Vdc}, I_D = 30 \text{ Adc},$	t _r	_	200	400	
Turn-Off Delay Time	$V_{GS} = 5.0 \text{ Vdc}, R_G = 9.1 \Omega) \text{ (Note 1)}$	t _{d(off)}	_	15.6	30	
Fall Time		t _f	-	62	120	
Gate Charge		Q _T	-	16	32	nC
	$(V_{DS} = 48 \text{ Vdc}, I_D = 30 \text{ Adc}, V_{GS} = 5.0 \text{ Vdc}) \text{ (Note 1)}$	Q ₁	-	3.9	_	
	36 11 11, (14)	Q_2	-	10	-	
SOURCE-DRAIN DIODE CHARA	CTERISTICS					
Forward On-Voltage	$(I_S = 30 \text{ Adc}, V_{GS} = 0 \text{ Vdc}) \text{ (Note 1)}$ $(I_S = 30 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 150^{\circ}\text{C})$	V _{SD}	-	1.01 1.03	1.2 -	Vdc
Reverse Recovery Time		t _{rr}	-	50	-	ns
	$(I_S = 30 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, \\ dI_S/dt = 100 \text{ A/}\mu\text{s}) \text{ (Note 1)}$	t _a	-	32	-	
		t _b	-	17	-	
Reverse Recovery Stored Charge	Q_{RR}	-	0.082	-	μС	

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

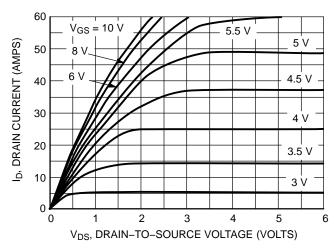


Figure 1. On-Region Characteristics

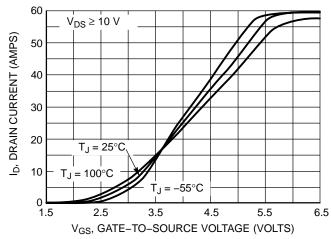


Figure 2. Transfer Characteristics

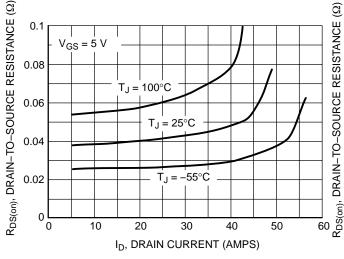


Figure 3. On–Resistance versus Gate–to–Source Voltage

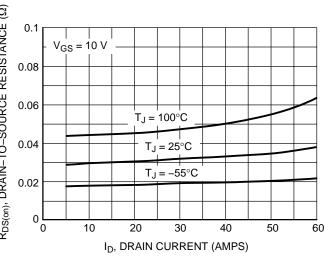


Figure 4. On-Resistance versus Drain Current and Gate Voltage

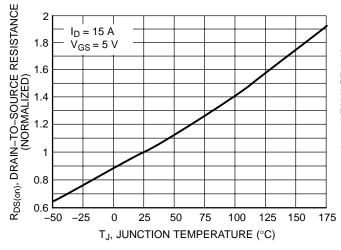


Figure 5. On–Resistance Variation with Temperature

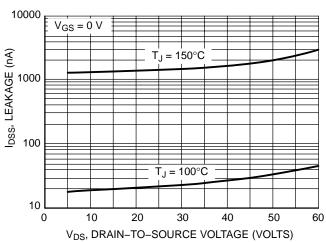


Figure 6. Drain-to-Source Leakage Current versus Voltage

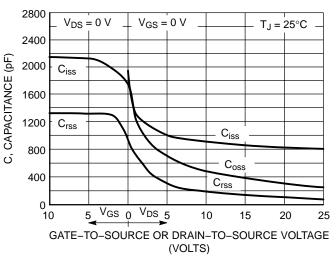


Figure 7. Capacitance Variation

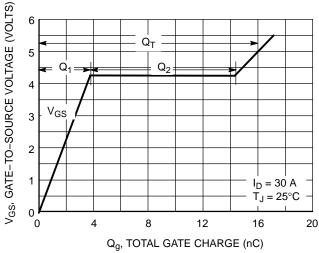


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

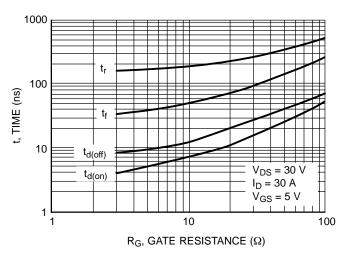


Figure 9. Resistive Switching Time Variation versus Gate Resistance

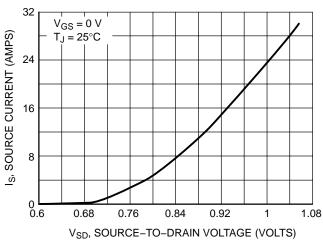


Figure 10. Diode Forward Voltage versus
Current

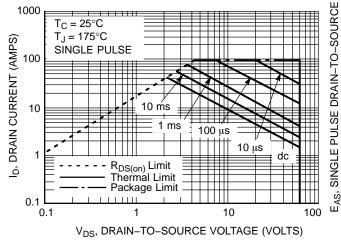


Figure 11. Maximum Rated Forward Biased Safe Operating Area

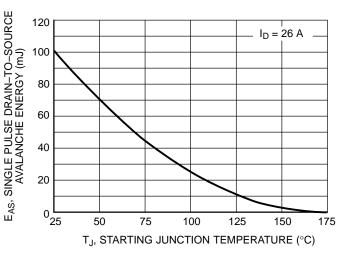


Figure 12. Maximum Avalanche Energy versus Starting Junction Temperature

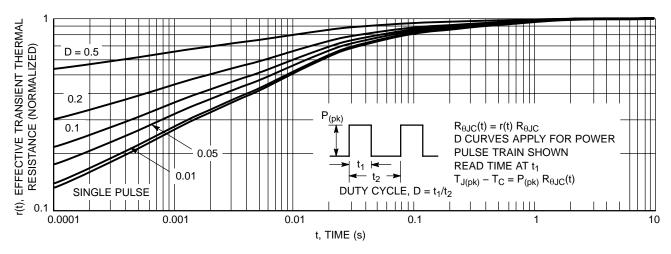


Figure 13. Thermal Response

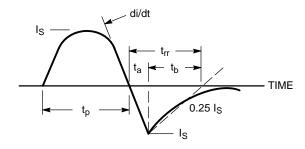


Figure 14. Diode Reverse Recovery Waveform

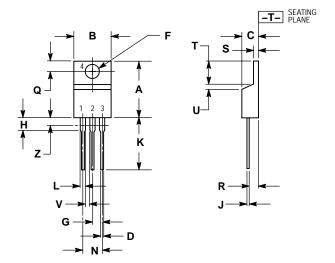
ORDERING INFORMATION

Device	Package	Shipping [†]
NTP30N06L	TO-220	50 Units / Rail
NTP30N06LG	TO-220 (Pb-Free)	50 Units / Rail
NTB30N06L	D ² PAK	50 Units / Rail
NTB30N06LG	D ² PAK (Pb-Free)	50 Units / Rail
NTB30N06LT4	D ² PAK	800 Tape & Reel
NTB30N06LT4G	D ² PAK (Pb-Free)	800 Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

TO-220 CASE 221A-09 ISSUE AA



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

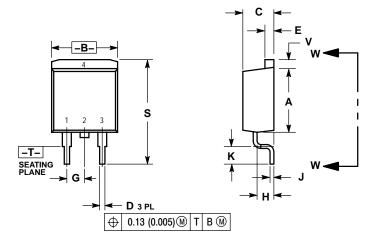
	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.147	3.61	3.73
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.018	0.025	0.46	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

- STYLE 5:
 PIN 1. GATE
 2. DRAIN
 3. SOURCE
 4. DRAIN

PACKAGE DIMENSIONS

D²PAK

CASE 418B-04 **ISSUE J**

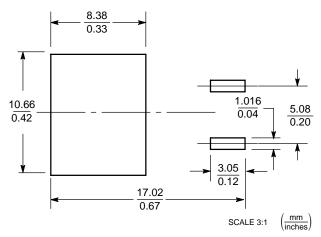


- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. 418B-01 THRU 418B-03 OBSOLETE, NEW STANDARD 418B-04.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.340	0.380	8.64	9.65
В	0.380	0.405	9.65	10.29
С	0.160	0.190	4.06	4.83
D	0.020	0.035	0.51	0.89
E	0.045	0.055	1.14	1.40
F	0.310	0.350	7.87	8.89
G	0.100 BSC		2.54 BSC	
Н	0.080	0.110	2.03	2.79
J	0.018	0.025	0.46	0.64
K	0.090	0.110	2.29	2.79
L	0.052	0.072	1.32	1.83
M	0.280	0.320	7.11	8.13
N	0.197 REF		5.00 REF	
Р	0.079 REF		2.00 REF	
R	0.039 REF		0.99 REF	
S	0.575	0.625	14.60	15.88
٧	0.045	0.055	1.14	1.40

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and the registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 61312, Phoenix, Arizona 85082–1312 USA Phone: 480–829–7710 or 800–344–3860 Toll Free USA/Canada Fax: 480–829–7709 or 800–344–3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800–282–9855 Toll Free USA/Canada

Japan: ON Semiconductor, Japan Customer Focus Center 2–9–1 Kamimeguro, Meguro–ku, Tokyo, Japan 153–0051 Phone: 81–3–5773–3850

ON Semiconductor Website: http://onsemi.com

Order Literature: http://www.onsemi.com/litorder

For additional information, please contact your local Sales Representative.